

Notice of References Cited	Application/Control No. 10/692,854	Applicant(s)/Patent Under Reexamination KANEKO ET AL.	
	Examiner Tran N. Nguyen	Art Unit 2834	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,316,112	02-1982	Waldron et al.	310/258
	B	US-6,759,778	07-2004	Nishiyama et al.	310/156.53
	C	US-2005/0040716	02-2005	Schmid et al.	310/071
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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